

Main Product Characteristics

I_D	7A
V_{DSS}	650V
$P_D(T_C=25^{\circ}C)$	95W
$R_{DS(ON)Typ}$	1.1 Ω

Features

- Fast switching.
- ESD improved capability.
- Low gate charge. (Typical Data:24nC)
- Low reverse transfer capacitances. (Typical:4.5pF)
- 100% single pulse avalanche energy test.

Application

- Power switch circuit of adaptor and charger.

Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : JEDEC TO-251 molded plastic body over passivated chip
- Lead : Axial leads, solderable per MIL-STD-202, Method 208 guaranteed.

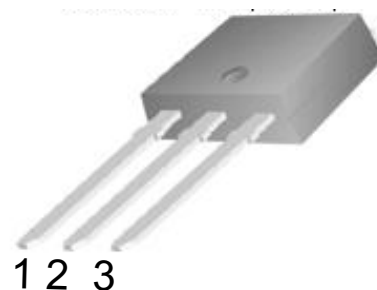
Absolute($T_C = 25^{\circ}C$ unless otherwise specified)

PARAMETER	CONDITIONS	Symbol	MHU07N65	UNIT
Drain-to-Source Voltage		V_{DSS}	650	V
Continuous Drain Current		I_D	7	A
Continuous Drain Current	$T_C = 100^{\circ}C$		4.5	
Pulsed Drain Current(Note:1)			28	
Gate-to-Source Voltage		V_{GS}	± 30	V
Single Pulse Avalanche Energy(Note:2)		E_{AS}	450	mJ
Avalanche Current(Note:1)		I_{AR}	3.3	A
Avalanche Energy, Repetitive(Note:1)		E_{AR}	54	mJ
Power Dissipation	Power Dissipation	P_D	95	W
	Derating factor above 25 $^{\circ}C$		0.76	W/ $^{\circ}C$
Peak Diode Recovery dv/dt(Note:3)		dV/dt	5.0	V/ns
Gate source ESD	HBM-C = 100pF, R = 1.5k Ω	$V_{ESD(G-S)}$	3000	V
Operating Junction and Storage Temperature Range		T_J, T_{STG}	150, -55 ~ +150	$^{\circ}C$
Maximum temperature for soldering		T_L	300	$^{\circ}C$

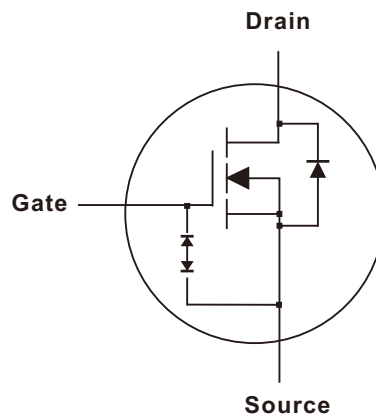
NOTE : 1.Repetitive rating; pulse width limited by maximum junction temperature.
2.L=10.0mH, $I_0 = 6.3A$, Start $T_J = 25^{\circ}C$.
3. $I_{SD} = 4A$, di/dt $\leq 100A/\mu s$, $V_{DD} \leq BV_{DS}$, Start $T_J = 25^{\circ}C$.

Outline

TO-251



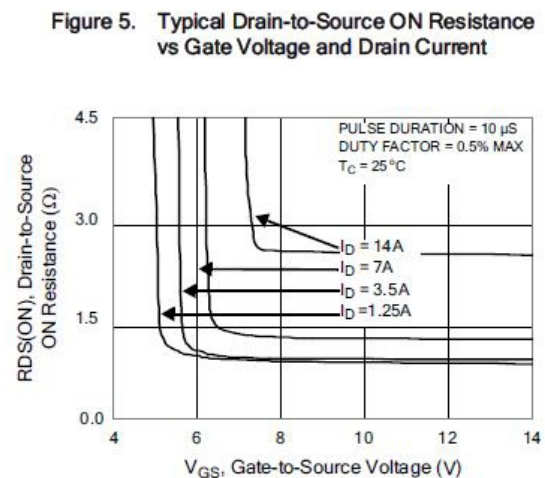
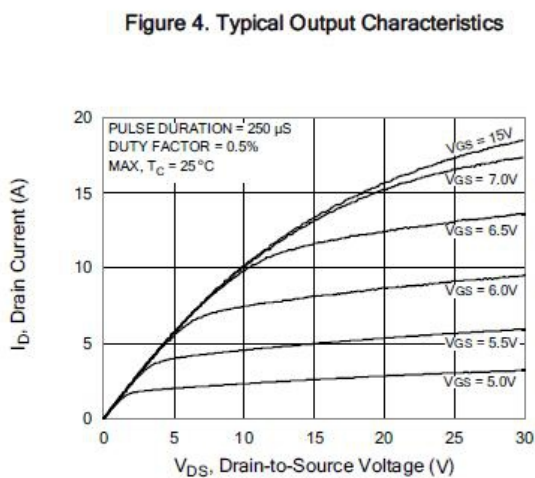
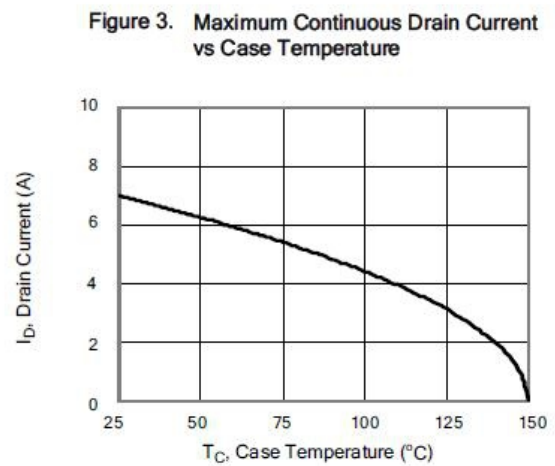
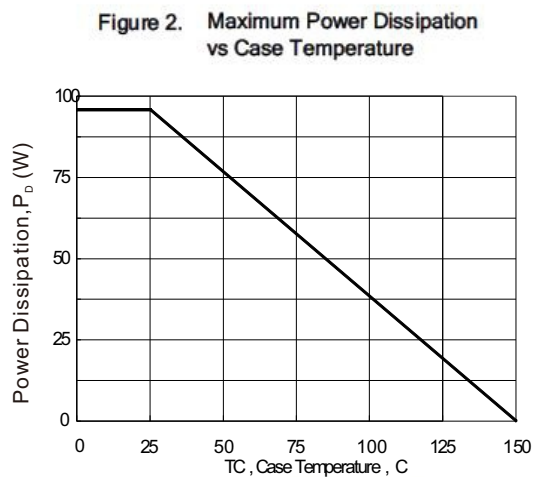
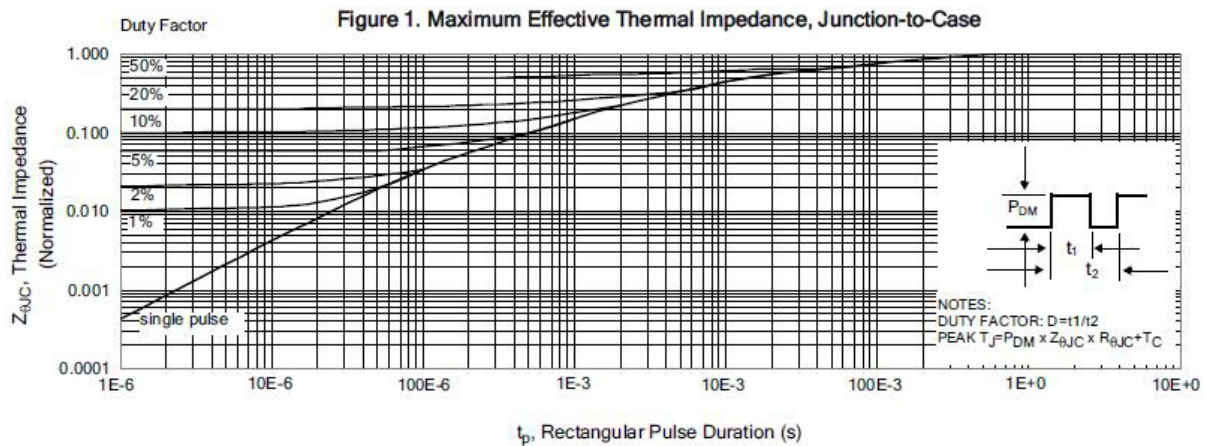
1.Gate 2.Drain 3.Source



Inner Equivalent principium Chart

■ Electrical characteristics(T _c = 25°C unless otherwise specified)						
■ OFF Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Drain to Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA	V _{DSS}	650			V
Bvdss Temperature Coefficient	I _D = 250μA, Reference 25°C	ΔBV _{DSS} /ΔT _J		0.67		V/°C
Drain to Source Leakage Current	V _{DS} = 650V, V _{GS} = 0V, T _a = 25°C	I _{DSS}			1	μA
	V _{DS} = 520V, V _{GS} = 0V, T _a = 125°C				100	
Gate to Source Forward Leakage	V _{GS} = +20V	I _{GSS(F)}			10	
Gate to Source Reverse Leakage	V _{GS} = -20V	I _{GSS(R)}			-10	
■ ON Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	V _{GS(th)}	2.0		4.0	V
Drain-to-Source On-Resistance	V _{GS} = 10V, I _D = 3.5A	R _{DS(on)}		1.1	1.4	Ω
Pulse Width tp≤300μs,δ≤2%						
■ Dynamic Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Forward Trans conductance	V _{DS} = 15V, I _D = 3.5A	g _{fs}		6.5		S
Input Capacitance	V _{DS} = 25V, V _{GS} = 0V, f = 1.0MHz	C _{iss}		1080		pF
Output Capacitance		C _{oss}		93		
Reverse Transfer Capacitance		C _{rss}		4.5		
■ Resistive Switching Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Turn-on Delay Time	I _D = 7A, V _{DD} = 520V, V _{GS} = 10V, R _G = 9.1Ω	td _(ON)		11		ns
Rise Time		tr		10		
Turn-off Delay Time		td _(OFF)		36		
Fail Time		tf		18		
Total Gate Charge	I _D = 7A, V _{DD} = 520V, V _{GS} = 10V	Q _g		24		nC
Gate toSource Charge		Q _{gs}		5		
Gate to Drain ("Miller") Charge		Q _{gd}		8		
■ Source-Drain Diode Characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Continuous Source Current	Boby Diode	I _s			7	A
Maximum Pulse Current	Boby Diode	I _{SM}			28	
Diode Forward Voltage	I _s = 7.0A, V _{GS} = 0V	V _{SD}			1.5	V
Reverse recovery time	I _s = 7A, T _J = 25°C, dI _F /dt = 100A/μs, V _{GS} = 0V	t _{rr}		280		ns
Reverse recovery charge		Q _{rr}		1200		nC
Pulse Width tp≤300μs,δ≤2%						
■ Thermal characteristics						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Thermal Resistance	Junction to Case	R _{θJC}		1.32		°C/W
	Junction to Ambient	R _{θJA}		62		
■ Gate-source Zener Diode						
PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Gate-Source Breakdown Voltage	I _{GS} = ±1mA(open Drain)	V _{GSO}	30			V

■ Rating and characteristic curves



■ Rating and characteristic curves

Figure 6. Maximum Peak Current Capability

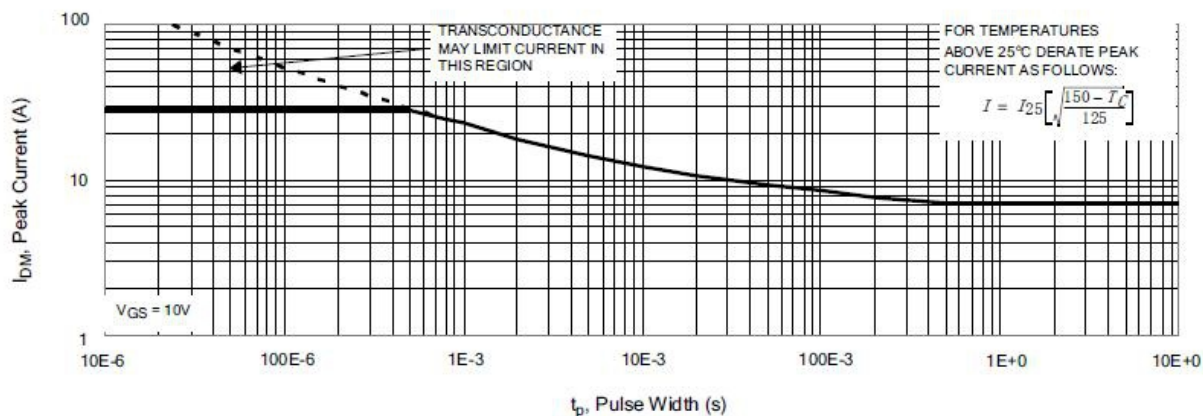


Figure 7. Typical Transfer Characteristics

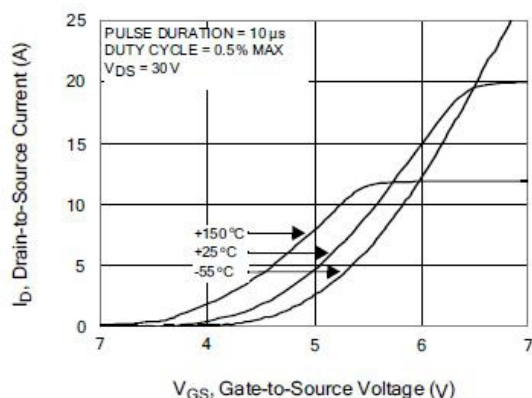


Figure 8. Unclamped Inductive Switching Capability

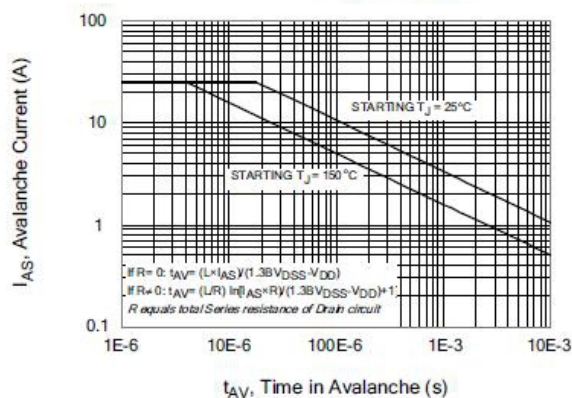


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

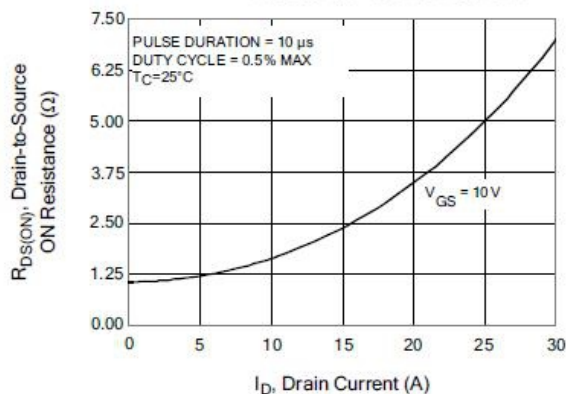
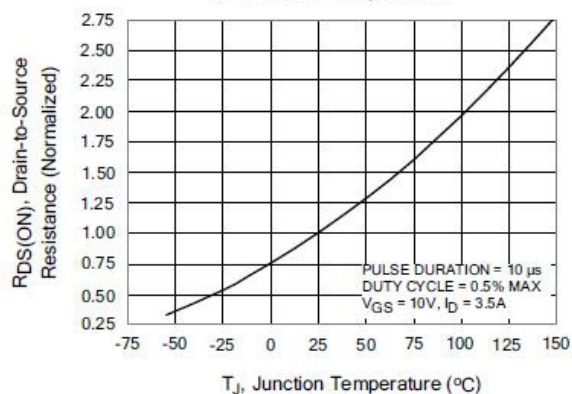


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature



■ Rating and characteristic curves

Figure 11. Typical Breakdown Voltage vs Junction Temperature

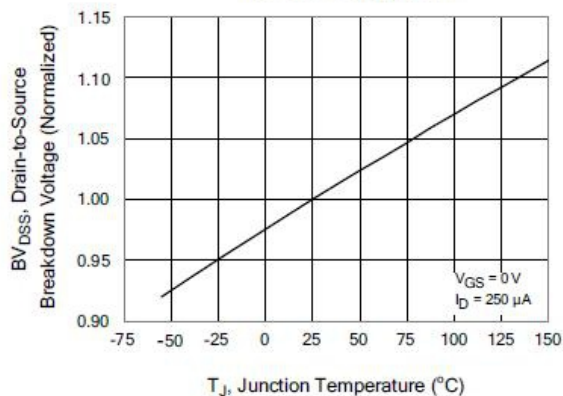


Figure 12. Typical Threshold Voltage vs Junction Temperature

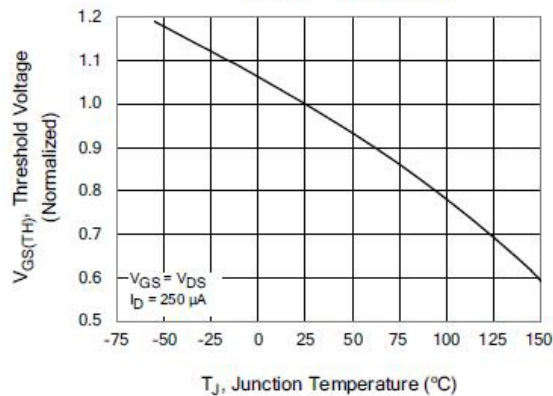


Figure 13. Maximum Forward Bias Safe Operating Area

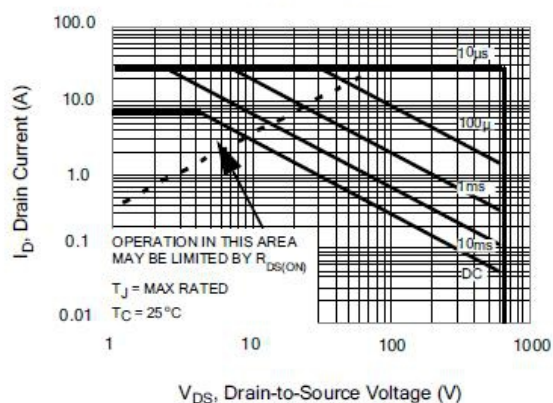


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

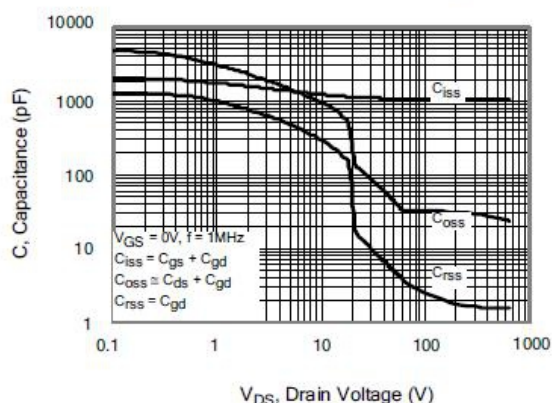


Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

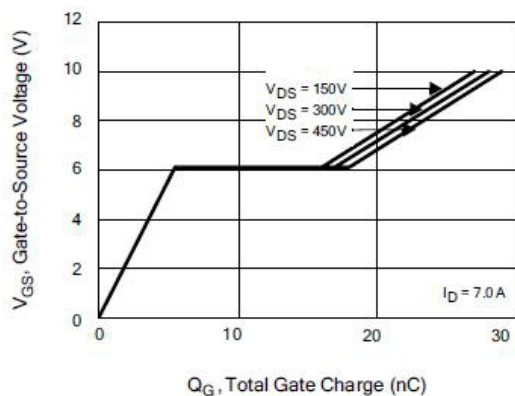
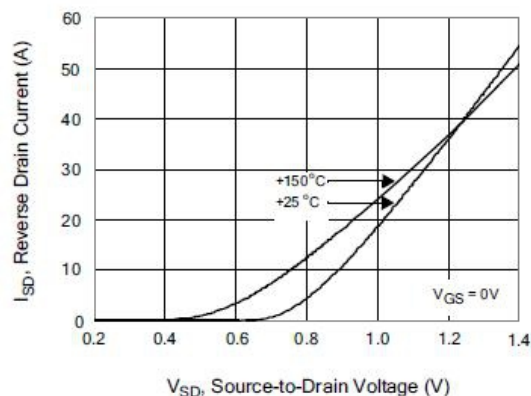


Figure 16. Typical Body Diode Transfer Characteristics



■ Test circuit and waveform

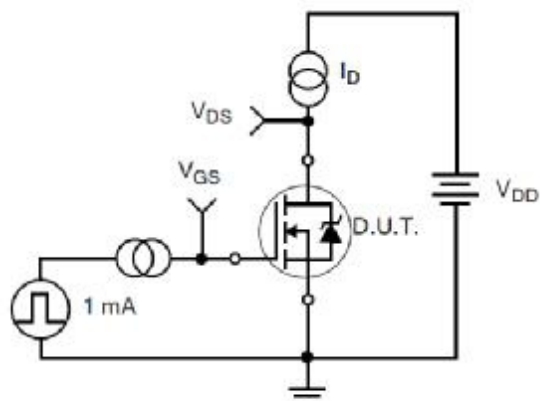


Figure 17. Gate Charge Test Circuit

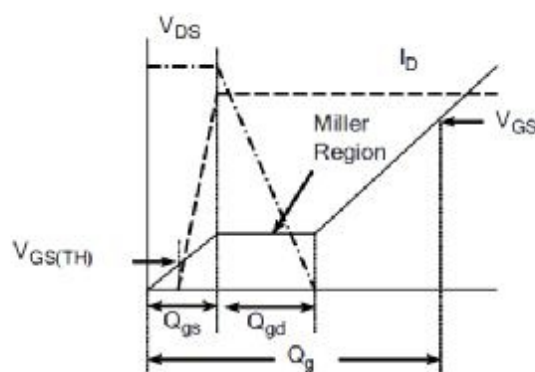


Figure 18. Gate Charge Waveform

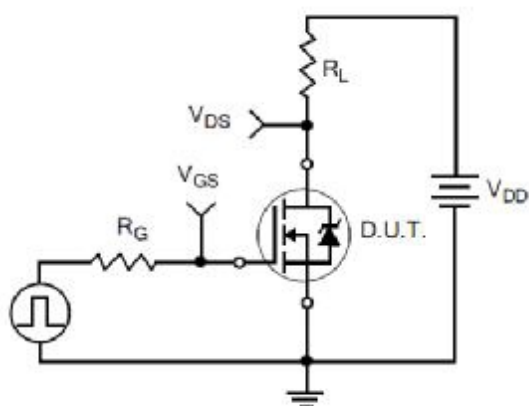


Figure 19. Resistive Switching Test Circuit

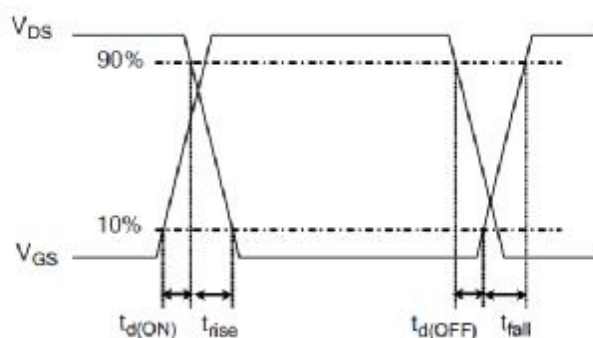


Figure 20. Resistive Switching Waveforms

■ Test circuit and waveform

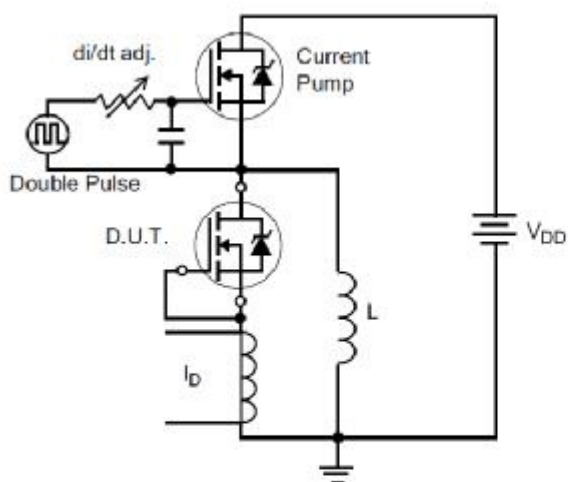


Figure 21. Diode Reverse Recovery Test Circuit

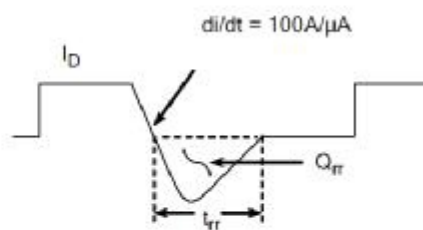


Figure 22. Diode Reverse Recovery Waveform

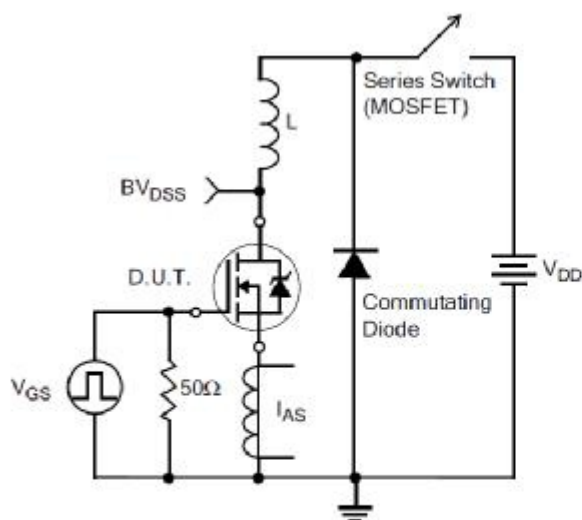


Figure 23. Unclamped Inductive Switching Test Circuit

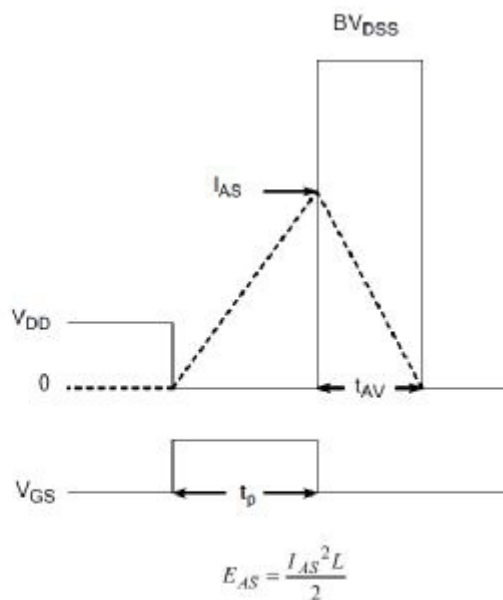
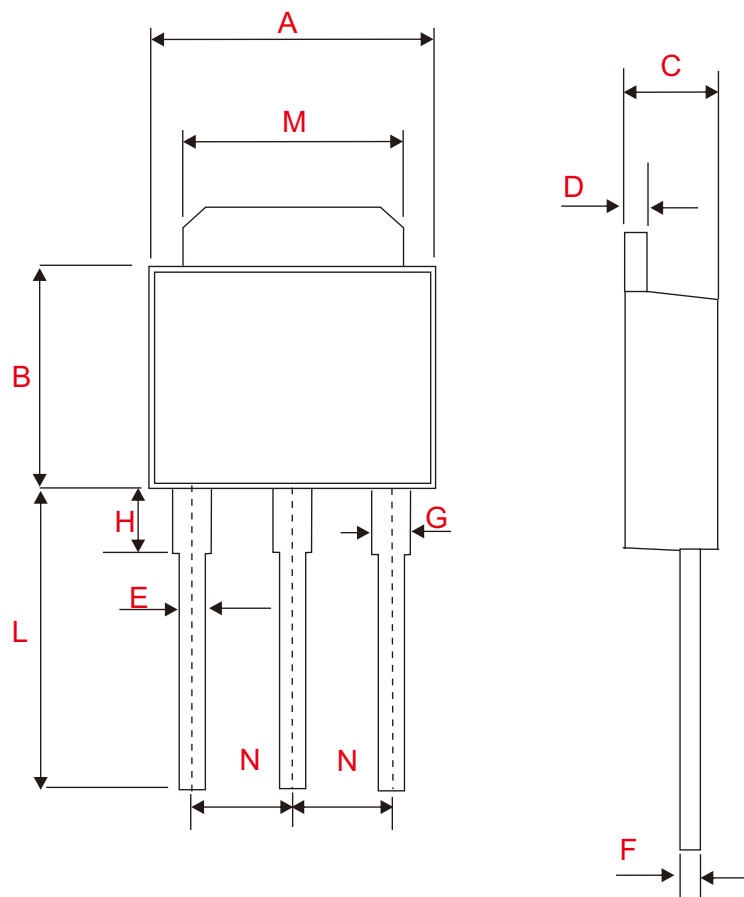


Figure 24. Unclamped Inductive Switching Waveforms

■ Package Information



Item	Values (mm)	
	Min	Max
A	6.30	6.90
B	5.70	6.30
C	2.10	2.50
D	0.30	0.60
E	0.50	0.70
F	0.30	0.60
G	0.70	1.00
H	1.60	2.40
L	7.70	9.80
	6.00	6.30
	4.50	5.80
	2.10	3.70
M	5.10	5.50
N	2.09	2.49

TO-251 Package

The name and content of poisonous and harmful material in products

Parts Name	Hazardous Substance					
	Pb	Hg	Cd	Cr(VI)	PBB	PBDE
Limit	≤0.1%	≤0.1%	≤0.01%	≤0.1%	≤0.1%	≤0.1%
Lead Frame	○	○	○	○	○	○
Molding Compound	○	○	○	○	○	○
Chip	○	○	○	○	○	○
Wire Bonding	○	○	○	○	○	○
Solder	×	○	○	○	○	○
Note	○: means the hazardous material is under the criterion of SJ/T11363-2006. ×: means the hazardous material exceeds the criterion of SJ/T11363-2006. The plumbum element of solder exist in products presently, but within the allowed range of Eurogroup RoHS.					

Warnings

1. Exceeding the maximum ratings of the device in performance may cause damage to the device, even the permanent failure, which may affect the dependability of the machine. It is suggested to be used under 80 percent of the maximum ratings of the device.
2. When installing the heatsink, please pay attention to the torsional moment and the smoothness of the heatsink.
3. VDMOSFETs is the device which is sensitive to the static electricity, it is necessary to protect the device from being damaged by the static electricity when using it.
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